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Understanding Embedded - CPLDs (Complex Programmable Logic Devices)

Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixed-function ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

Applications of Embedded - CPLDs

Details

Product Status	Active
Programmable Type	In System Programmable
Delay Time tpd(1) Max	5.8 ns
Voltage Supply - Internal	1.7V ~ 1.9V
Number of Logic Elements/Blocks	4
Number of Macrocells	64
Number of Gates	-
Number of I/O	32
Operating Temperature	0°C ~ 90°C (TJ)
Mounting Type	Surface Mount
Package / Case	48-LQFP
Supplier Device Package	48-TQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/lattice-semiconductor/lc4064ze-5tn48c

Introduction

The high performance ispMACH 4000ZE family from Lattice offers an ultra low power CPLD solution. The new family is based on Lattice’s industry-leading ispMACH 4000 architecture. Retaining the best of the previous generation, the ispMACH 4000ZE architecture focuses on significant innovations to combine high performance with low power in a flexible CPLD family. For example, the family’s new Power Guard feature minimizes dynamic power consumption by preventing internal logic toggling due to unnecessary I/O pin activity.

The ispMACH 4000ZE combines high speed and low power with the flexibility needed for ease of design. With its robust Global Routing Pool and Output Routing Pool, this family delivers excellent First-Time-Fit, timing predictability, routing, pin-out retention and density migration.

The ispMACH 4000ZE family offers densities ranging from 32 to 256 macrocells. There are multiple density-I/O combinations in Thin Quad Flat Pack (TQFP), Chip Scale BGA (csBGA), and Ultra Chip Scale BGA (ucBGA) packages ranging from 32 to 144 pins/balls. Table 1 shows the macrocell, package and I/O options, along with other key parameters.

A user programmable internal oscillator and a timer are included in the device for tasks like LED control, keyboard scanner and similar housekeeping type state machines. This feature can be optionally disabled to save power.

The ispMACH 4000ZE family has enhanced system integration capabilities. It supports a 1.8V supply voltage and 3.3V, 2.5V, 1.8V and 1.5V interface voltages. Additionally, inputs can be safely driven up to 5.5V when an I/O bank is configured for 3.3V operation, making this family 5V tolerant. The ispMACH 4000ZE also offers enhanced I/O features such as slew rate control, PCI compatibility, bus-keeper latches, pull-up resistors, pull-down resistors, open drain outputs and hot socketing. Pull-up, pull-down and bus-keeper features are controllable on a “per-pin” basis. The ispMACH 4000ZE family members are 1.8V in-system programmable through the IEEE Standard 1532 interface. IEEE Standard 1149.1 boundary scan testing capability also allows product testing on automated test equipment. The 1532 interface signals TCK, TMS, TDI and TDO are referenced to V_{CC} (logic core).

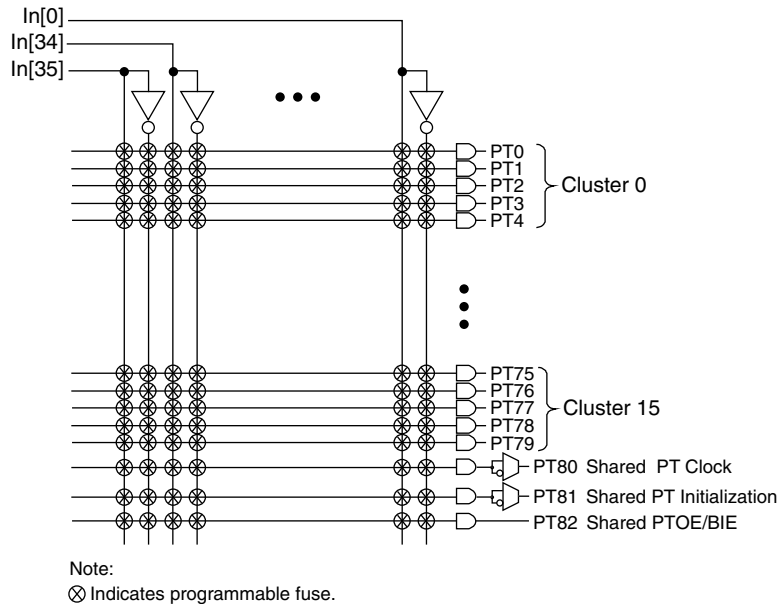
Overview

The ispMACH 4000ZE devices consist of multiple 36-input, 16-macrocell Generic Logic Blocks (GLBs) interconnected by a Global Routing Pool (GRP). Output Routing Pools (ORPs) connect the GLBs to the I/O Blocks (IOBs), which contain multiple I/O cells. This architecture is shown in Figure 1.

Figure 1. Functional Block Diagram



Figure 3. AND Array



Enhanced Logic Allocator

Within the logic allocator, product terms are allocated to macrocells in product term clusters. Each product term cluster is associated with a macrocell. The cluster size for the ispMACH 4000ZE family is 4+1 (total 5) product terms. The software automatically considers the availability and distribution of product term clusters as it fits the functions within a GLB. The logic allocator is designed to provide two speed paths: 20-PT Speed Locking path and an up to 80-PT path. The availability of these two paths lets designers trade timing variability for increased performance.

The enhanced Logic Allocator of the ispMACH 4000ZE family consists of the following blocks:

- Product Term Allocator
- Cluster Allocator
- Wide Steering Logic

Figure 4 shows a macrocell slice of the Logic Allocator. There are 16 such slices in the GLB.

Figure 4. Macrocell Slice

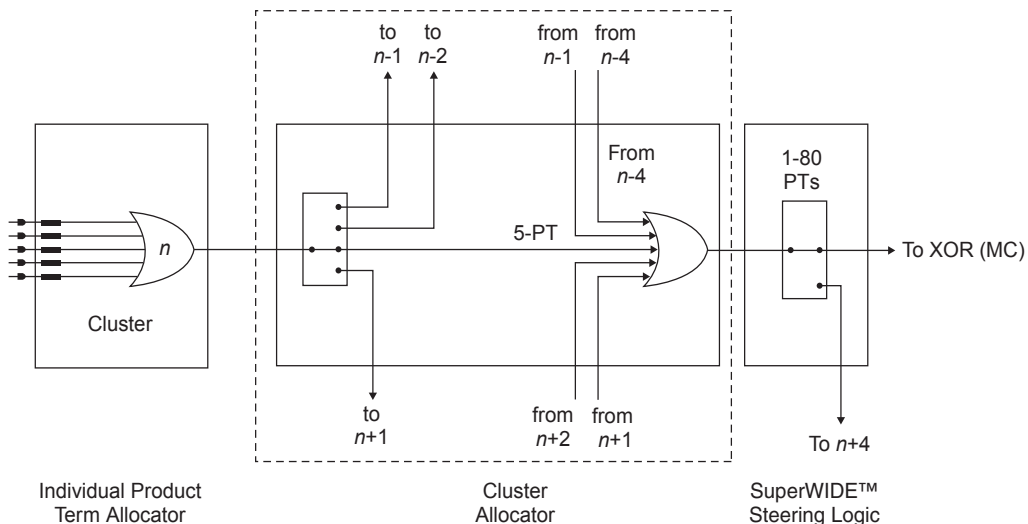


Table 4. Product Term Expansion Capability

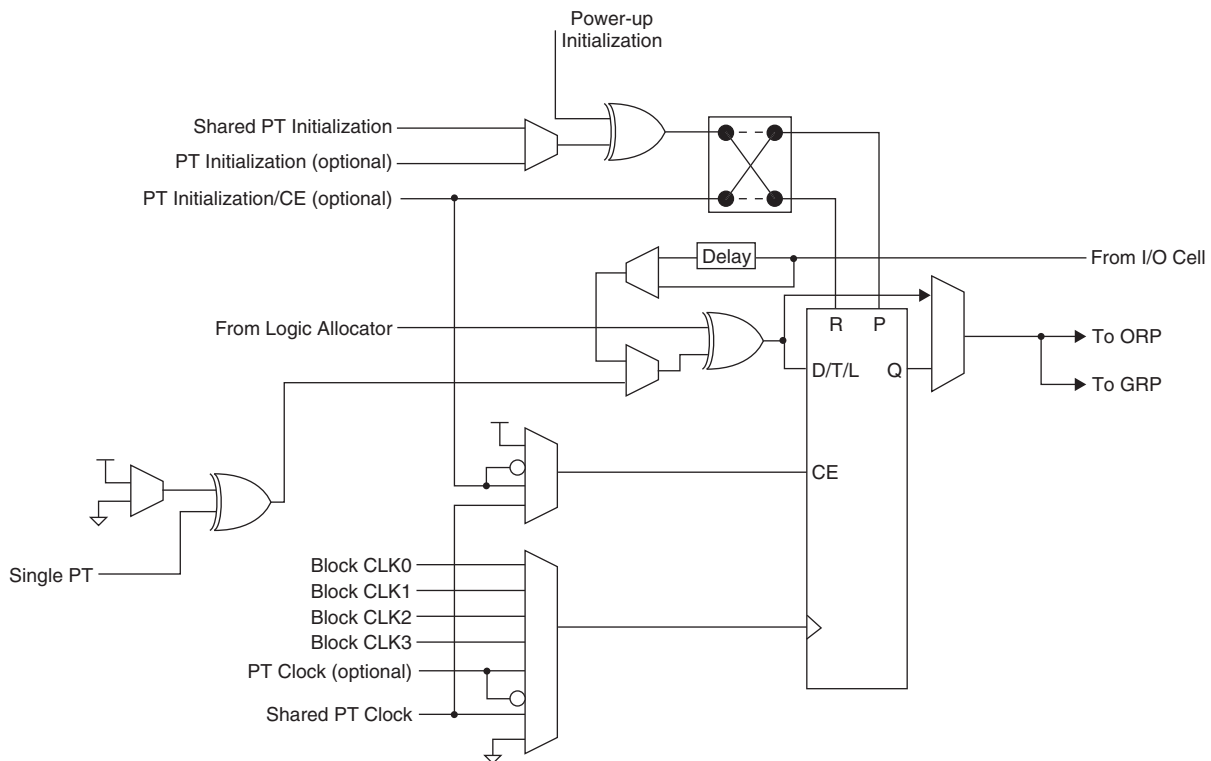
Expansion Chains	Macrocells Associated with Expansion Chain (with Wrap Around)	Max PT/Macrocell
Chain-0	M0 Õ M4 Õ M8 Õ M12 Õ M0	75
Chain-1	M1 Õ M5 Õ M9 Õ M13 Õ M1	80
Chain-2	M2 Õ M6 Õ M10 Õ M14 Õ M2	75
Chain-3	M3 Õ M7 Õ M11 Õ M15 Õ M3	70

Every time the super cluster allocator is used, there is an incremental delay of t_{EXP} . When the super cluster allocator is used, all destinations other than the one being steered to, are given the value of ground (i.e., if the super cluster is steered to M (n+4), then M (n) is ground).

Macrocell

The 16 macrocells in the GLB are driven by the 16 outputs from the logic allocator. Each macrocell contains a programmable XOR gate, a programmable register/latch, along with routing for the logic and control functions. Figure 5 shows a graphical representation of the macrocell. The macrocells feed the ORP and GRP. A direct input from the I/O cell allows designers to use the macrocell to construct high-speed input registers. A programmable delay in this path allows designers to choose between the fastest possible set-up time and zero hold time.

Figure 5. Macrocell

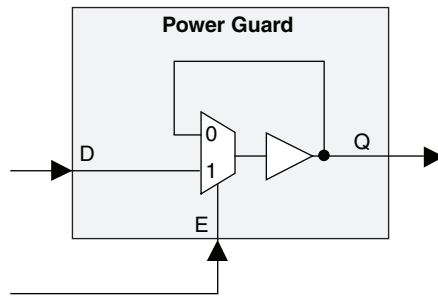


Enhanced Clock Multiplexer

The clock input to the flip-flop can select any of the four block clocks along with the shared PT clock, and true and complement forms of the optional individual term clock. An 8:1 multiplexer structure is used to select the clock. The eight sources for the clock multiplexer are as follows:

- Block CLK0
- Block CLK1

Figure 9. Power Guard

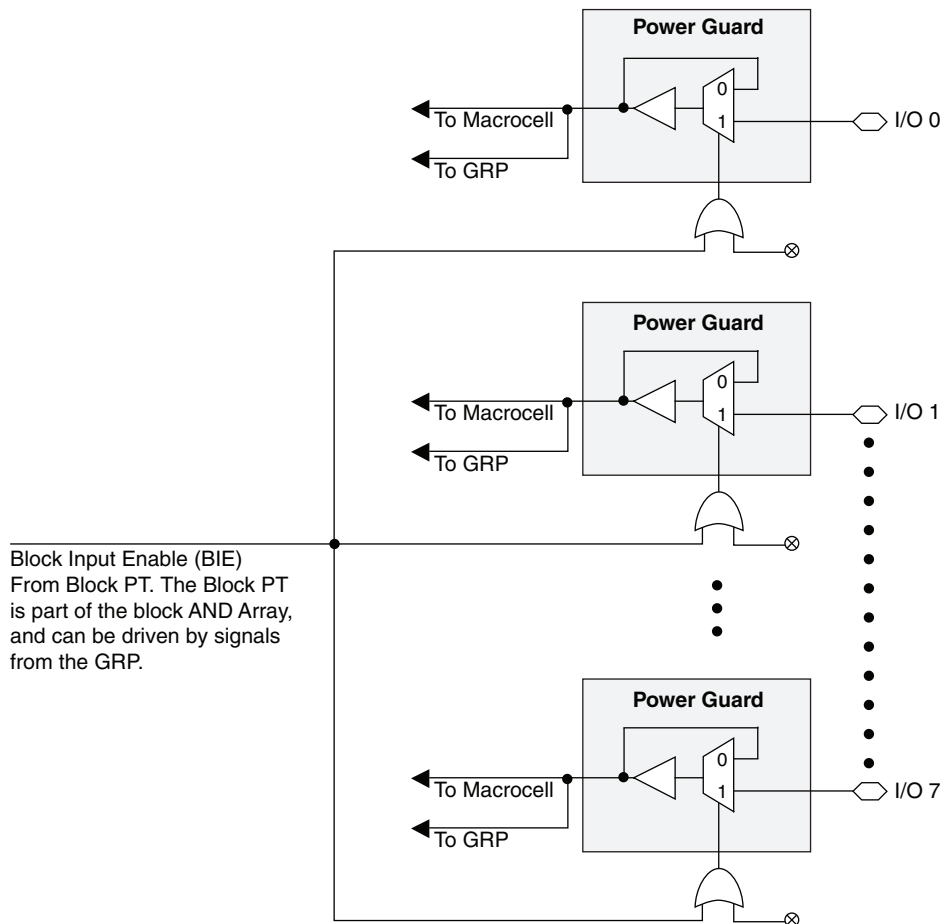


All the I/O pins in a block share a common Power Guard Enable signal. For a block of I/Os, this signal is called a Block Input Enable (BIE) signal. BIE can be internally generated using MC logic, or could come from external sources using one of the user I/O or input pins.

Any I/O pin in the block can be programmed to ignore the BIE signal. Thus, the feature can be enabled or disabled on a pin-by-pin basis.

Figure 10 shows Power Guard and BIE across multiple I/Os in a block that has eight I/Os.

Figure 10. Power Guard and BIE in a Block with 8 I/Os



The number of BIE inputs, thus the number of Power Guard “Blocks” that can exist in a device, depends on the device size. Table 8 shows the number of BIE signals available in the ispMACH 4000ZE family. The number of I/Os available in each block is shown in the Ordering Information section of this data sheet.

Table 8. Number of BIE Signals Available in ispMACH 4000ZE Devices

Device	Number of Logic Blocks, Power Guard Blocks and BIE Signals
ispMACH 4032ZE	Two (Blocks: A and B)
ispMACH 4064ZE	Four (Blocks: A, B, C and D)
ispMACH 4128ZE	Eight (Blocks: A, B, C, ..., H)
ispMACH 4256ZE	Sixteen (Blocks: A, B, C, ..., P)

Power Guard for Dedicated Inputs

Power Guard can optionally be applied to the dedicated inputs. The dedicated inputs and clocks are controlled by the BIE of the logic blocks shown in Tables 9 and 10.

Table 9. Dedicated Clock Inputs to BIE Association

CLK/I	32 MC Block	64MC Block	128MC Block	256MC Block
CLK0 / I	A	A	A	A
CLK1 / I	A	B	D	H
CLK2 / I	B	C	E	I
CLK3 / I	B	D	H	P

Table 10. Dedicated Inputs to BIE Association

Dedicated Input	4064ZE Block	4128ZE Block	4256ZE Block
0	A	B	D
1	B	C	E
2	B	D	G
3	C	F	G
4	D	G	J
5	D	H	L
6	—	—	M
7	—	—	O
8	—	—	O
9	—	—	B

For more information on the Power Guard function refer to TN1174, [Advanced Features of the ispMACH 4000ZE Family](#).

Global OE (GOE) and Block Input Enable (BIE) Generation

Most ispMACH 4000ZE family devices have a 4-bit wide Global OE (GOE) Bus (Figure 11), except the ispMACH 4032 device that has a 2-bit wide Global OE Bus (Figure 12). This bus is derived from a 4-bit internal global OE (GOE) PT bus and two dual purpose I/O or GOE pins. Each signal that drives the bus can optionally be inverted.

Each GLB has a block-level OE PT that connects to all bits of the Global OE PT bus with four fuses. Hence, for a 256-macrocell device (with 16 blocks), each line of the bus is driven from 16 OE product terms. Figures 9 and 10 show a graphical representation of the global OE generation.

Table 12. OSC and TIMER MC Designation

Device	Macrocell	Block Number	MC Number
ispMACH 4032ZE	OSC MC	A	15
	TIMER MC	B	15
ispMACH 4064ZE	OSC MC	A	15
	TIMER MC	D	15
ispMACH 4128ZE	OSC MC	A	15
	TIMER MC	G	15
ispMACH 4256ZE	OSC MC	C	15
	TIMER MC	F	15

Zero Power/Low Power and Power Management

The ispMACH 4000ZE family is designed with high speed low power design techniques to offer both high speed and low power. With an advanced E² low power cell and non sense-amplifier design approach (full CMOS logic approach), the ispMACH 4000ZE family offers fast pin-to-pin speeds, while simultaneously delivering low standby power without needing any “turbo bits” or other power management schemes associated with a traditional sense-amplifier approach.

The zero power ispMACH 4000ZE is based on the 1.8V ispMACH 4000Z family. With innovative circuit design changes, the ispMACH 4000ZE family is able to achieve the industry’s lowest static power.

IEEE 1149.1-Compliant Boundary Scan Testability

All ispMACH 4000ZE devices have boundary scan cells and are compliant to the IEEE 1149.1 standard. This allows functional testing of the circuit board on which the device is mounted through a serial scan path that can access all critical logic nodes. Internal registers are linked internally, allowing test data to be shifted in and loaded directly onto test nodes, or test node data to be captured and shifted out for verification. In addition, these devices can be linked into a board-level serial scan path for more board-level testing. The test access port operates with an LVCMOS interface that corresponds to the power supply voltage.

I/O Quick Configuration

To facilitate the most efficient board test, the physical nature of the I/O cells must be set before running any continuity tests. As these tests are fast, by nature, the overhead and time that is required for configuration of the I/Os’ physical nature should be minimal so that board test time is minimized. The ispMACH 4000ZE family of devices allows this by offering the user the ability to quickly configure the physical nature of the I/O cells. This quick configuration takes milliseconds to complete, whereas it takes seconds for the entire device to be programmed. Lattice’s ispVM™ System programming software can either perform the quick configuration through the PC parallel port, or can generate the ATE or test vectors necessary for a third-party test system.

IEEE 1532-Compliant In-System Programming

Programming devices in-system provides a number of significant benefits including: rapid prototyping, lower inventory levels, higher quality and the ability to make in-field modifications. All ispMACH 4000ZE devices provide In-System Programming (ISP™) capability through the Boundary Scan Test Access Port. This capability has been implemented in a manner that ensures that the port remains complaint to the IEEE 1149.1 standard. By using IEEE 1149.1 as the communication interface through which ISP is achieved, users get the benefit of a standard, well-defined interface. All ispMACH 4000ZE devices are also compliant with the IEEE 1532 standard.

The ispMACH 4000ZE devices can be programmed across the commercial temperature and voltage range. The PC-based Lattice software facilitates in-system programming of ispMACH 4000ZE devices. The software takes the JEDEC file output produced by the design implementation software, along with information about the scan chain, and creates a set of vectors used to drive the scan chain. The software can use these vectors to drive a scan chain via the parallel port of a PC. Alternatively, the software can output files in formats understood by common auto-

Absolute Maximum Ratings^{1, 2, 3, 4}

Supply Voltage (V_{CC}) -0.5 to 2.5V
 Output Supply Voltage (V_{CCO}) -0.5 to 4.5V
 Input or I/O Tristate Voltage Applied^{5, 6} -0.5 to 5.5V
 Storage Temperature -65 to 150°C
 Junction Temperature (T_j) with Power Applied . . . -55 to 150°C

1. Stress above those listed under the “Absolute Maximum Ratings” may cause permanent damage to the device. Functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.
2. Compliance with Lattice [Thermal Management](#) document is required.
3. All voltages referenced to GND.
4. Please refer to the [Lattice ispMACH 4000V/B/C/ZC/ZE Product Family Qualification Summary](#) for complete data, including the ESD performance data.
5. Undershoot of -2V and overshoot of (V_{IH} (MAX) + 2V), up to a total pin voltage of 6V is permitted for a duration of <20ns.
6. Maximum of 64 I/Os per device with $V_{IN} > 3.6V$ is allowed.

Recommended Operating Conditions

Symbol	Parameter	Min.	Max.	Units	
V_{CC}	Supply Voltage	Standard Voltage Operation	1.7	1.9	V
		Extended Voltage Operation	1.6 ¹	1.9	V
T_j	Junction Temperature (Commercial)	0	90	°C	
	Junction Temperature (Industrial)	-40	105	°C	

1. Devices operating at 1.6V can expect performance degradation up to 35%.

Erase Reprogram Specifications

Parameter	Min.	Max.	Units
Erase/Reprogram Cycle	1,000	—	Cycles

Note: Valid over commercial temperature range.

Hot Socketing Characteristics^{1,2,3}

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
I_{DK}	Input or I/O Leakage Current	$0 \leq V_{IN} \leq 3.0V, T_j = 105^\circ C$	—	±30	±150	µA
		$0 \leq V_{IN} \leq 3.0V, T_j = 130^\circ C$	—	±30	±200	µA

1. Insensitive to sequence of V_{CC} or V_{CCO} . However, assumes monotonic rise/fall rates for V_{CC} and V_{CCO} , provided $(V_{IN} - V_{CCO}) \leq 3.6V$.

2. $0 < V_{CC} < V_{CC} (MAX), 0 < V_{CCO} < V_{CCO} (MAX)$.

3. I_{DK} is additive to I_{PU}, I_{PD} or I_{BH} . Device defaults to pull-up until fuse circuitry is active.

Supply Current

To minimize transient current during power-on, configure CPLD I/Os to a pull-up or float state. If this logic scenario is not possible, then the recommended power sequence should assert VCC and VCCO at the same time or VCC before VCCO.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
ispMACH 4032ZE						
ICC ^{1, 2, 3, 5, 6}	Operating Power Supply Current	V _{CC} = 1.8V, T _A = 25°C	—	50	—	μA
		V _{CC} = 1.9V, T _A = 0 to 70°C	—	58	—	μA
		V _{CC} = 1.9V, T _A = -40 to 85°C	—	60	—	μA
ICC ^{4, 5, 6}	Standby Power Supply Current	V _{CC} = 1.8V, T _A = 25°C	—	10	—	μA
		V _{CC} = 1.9V, T _A = 0 to 70°C	—	13	25	μA
		V _{CC} = 1.9V, T _A = -40 to 85°C	—	15	40	μA
ispMACH 4064ZE						
ICC ^{1, 2, 3, 5, 6}	Operating Power Supply Current	V _{CC} = 1.8V, T _A = 25°C	—	80	—	μA
		V _{CC} = 1.9V, T _A = 0 to 70°C	—	89	—	μA
		V _{CC} = 1.9V, T _A = -40 to 85°C	—	92	—	μA
ICC ^{4, 5, 6}	Standby Power Supply Current	V _{CC} = 1.8V, T _A = 25°C	—	11	—	μA
		V _{CC} = 1.9V, T _A = 0 to 70°C	—	15	30	μA
		V _{CC} = 1.9V, T _A = -40 to 85°C	—	18	50	μA
ispMACH 4128ZE						
ICC ^{1, 2, 3, 5, 6}	Operating Power Supply Current	V _{CC} = 1.8V, T _A = 25°C	—	168	—	μA
		V _{CC} = 1.9V, T _A = 0 to 70°C	—	190	—	μA
		V _{CC} = 1.9V, T _A = -40 to 85°C	—	195	—	μA
ICC ^{4, 5, 6}	Standby Power Supply Current	V _{CC} = 1.8V, T _A = 25°C	—	12	—	μA
		V _{CC} = 1.9V, T _A = 0 to 70°C	—	16	40	μA
		V _{CC} = 1.9V, T _A = -40 to 85°C	—	19	60	μA
ispMACH 4256ZE						
ICC ^{1, 2, 3, 5, 6}	Operating Power Supply Current	V _{CC} = 1.8V, T _A = 25°C	—	341	—	μA
		V _{CC} = 1.9V, T _A = 0 to 70°C	—	361	—	μA
		V _{CC} = 1.9V, T _A = -40 to 85°C	—	372	—	μA
ICC ^{4, 5, 6}	Standby Power Supply Current	V _{CC} = 1.8V, T _A = 25°C	—	13	—	μA
		V _{CC} = 1.9V, T _A = 0 to 70°C	—	32	65	μA
		V _{CC} = 1.9V, T _A = -40 to 85°C	—	43	100	μA

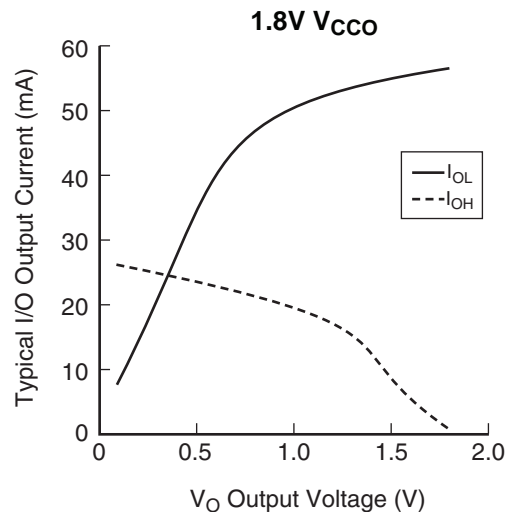
- Frequency = 1.0 MHz.
- Device configured with 16-bit counters.
- I_{CC} varies with specific device configuration and operating frequency.
- V_{CCO} = 3.6V, V_{IN} = 0V or V_{CCO}, bus maintenance turned off. V_{IN} above V_{CCO} will add transient current above the specified standby I_{CC}.
- Includes V_{CCO} current without output loading.
- This operating supply current is with the internal oscillator disabled. Enabling the internal oscillator adds approximately 15μA typical current plus additional current from any logic it drives.

I/O DC Electrical Characteristics

Over Recommended Operating Conditions

Standard	V_{IL}		V_{IH}		V_{OL} Max (V)	V_{OH} Min (V)	I_{OL}^1 (mA)	I_{OH}^1 (mA)
	Min (V)	Max (V)	Min (V)	Max (V)				
LVTTTL	-0.3	0.80	2.0	5.5	0.40	$V_{CCO} - 0.40$	8.0	-4.0
					0.20	$V_{CCO} - 0.20$	0.1	-0.1
LVCMOS 3.3	-0.3	0.80	2.0	5.5	0.40	$V_{CCO} - 0.40$	8.0	-4.0
					0.20	$V_{CCO} - 0.20$	0.1	-0.1
LVCMOS 2.5	-0.3	0.70	1.70	3.6	0.40	$V_{CCO} - 0.40$	8.0	-4.0
					0.20	$V_{CCO} - 0.20$	0.1	-0.1
LVCMOS 1.8	-0.3	$0.35 * V_{CC}$	$0.65 * V_{CC}$	3.6	0.40	$V_{CCO} - 0.45$	2.0	-2.0
					0.20	$V_{CCO} - 0.20$	0.1	-0.1
LVCMOS 1.5 ²	-0.3	$0.35 * V_{CC}$	$0.65 * V_{CC}$	3.6	0.40	$V_{CCO} - 0.45$	2.0	-2.0
					0.20	$V_{CCO} - 0.20$	0.1	-0.1
PCI 3.3	-0.3	$0.3 * 3.3 * (V_{CC} / 1.8)$	$0.5 * 3.3 * (V_{CC} / 1.8)$	5.5	$0.1 V_{CCO}$	$0.9 V_{CCO}$	1.5	-0.5

- The average DC current drawn by I/Os between adjacent bank GND connections, or between the last GND in an I/O bank and the end of the I/O bank, as shown in the logic signals connection table, shall not exceed $n * 8\text{mA}$. Where n is the number of I/Os between bank GND connections or between the last GND in a bank and the end of a bank.
- For 1.5V inputs, there may be an additional DC current drawn from V_{CC} , if the ispMACH 4000ZE V_{CC} and the V_{CC} of the driving device (V_{CCd-d} ; that determines steady state V_{IH}) are in the extreme range of their specifications. Typically, DC current drawn from V_{CC} will be $2\mu\text{A}$ per input.



ispMACH 400ZE Internal Timing Parameters

Over Recommended Operating Conditions

Parameter	Description	LC4032ZE		LC4064ZE		Units
		-4		-4		
		Min.	Max.	Min.	Max.	
In/Out Delays						
t_{IN}	Input Buffer Delay	—	0.85	—	0.90	ns
t_{GCLK_IN}	Global Clock Input Buffer Delay	—	1.60	—	1.60	ns
t_{GOE}	Global OE Pin Delay	—	2.25	—	2.25	ns
t_{BUF}	Delay through Output Buffer	—	0.75	—	0.90	ns
t_{EN}	Output Enable Time	—	2.25	—	2.25	ns
t_{DIS}	Output Disable Time	—	1.35	—	1.35	ns
t_{PGSU}	Input Power Guard Setup Time	—	3.30	—	3.55	ns
t_{PGH}	Input Power Guard Hold Time	—	0.00	—	0.00	ns
t_{PGPW}	Input Power Guard BIE Minimum Pulse Width	—	5.00	—	5.00	ns
t_{PGRT}	Input Power Guard Recovery Time Following BIE Dissertation	—	5.00	—	5.00	ns
Routing Delays						
t_{ROUTE}	Delay through GRP	—	1.60	—	1.70	ns
t_{PDI}	Macrocell Propagation Delay	—	0.25	—	0.25	ns
t_{MCELL}	Macrocell Delay	—	0.65	—	0.65	ns
t_{INREG}	Input Buffer to Macrocell Register Delay	—	0.90	—	1.00	ns
t_{FBK}	Internal Feedback Delay	—	0.55	—	0.55	ns
t_{ORP}	Output Routing Pool Delay	—	0.30	—	0.30	ns
Register/Latch Delays						
t_S	D-Register Setup Time (Global Clock)	0.70	—	0.85	—	ns
t_{S_PT}	D-Register Setup Time (Product Term Clock)	1.25	—	1.85	—	ns
t_H	D-Register Hold Time	1.50	—	1.65	—	ns
t_{ST}	T-Register Setup Time (Global Clock)	0.90	—	1.05	—	ns
t_{ST_PT}	T-register Setup Time (Product Term Clock)	1.45	—	1.65	—	ns
t_{HT}	T-Resister Hold Time	1.50	—	1.65	—	ns
t_{SIR}	D-Input Register Setup Time (Global Clock)	0.85	—	0.80	—	ns
t_{SIR_PT}	D-Input Register Setup Time (Product Term Clock)	1.45	—	1.45	—	ns
t_{HIR}	D-Input Register Hold Time (Global Clock)	1.15	—	1.30	—	ns
t_{HIR_PT}	D-Input Register Hold Time (Product Term Clock)	0.90	—	1.10	—	ns
t_{COi}	Register Clock to Output/Feedback MUX Time	—	0.35	—	0.40	ns
t_{CES}	Clock Enable Setup Time	1.00	—	2.00	—	ns
t_{CEH}	Clock Enable Hold Time	0.00	—	0.00	—	ns
t_{SL}	Latch Setup Time (Global Clock)	0.70	—	0.95	—	ns
t_{SL_PT}	Latch Setup Time (Product Term Clock)	1.45	—	1.85	—	ns
t_{HL}	Latch Hold Time	1.40	—	1.80	—	ns
t_{GOi}	Latch Gate to Output/Feedback MUX Time	—	0.40	—	0.35	ns
t_{PDLi}	Propagation Delay through Transparent Latch to Output/Feedback MUX	—	0.30	—	0.25	ns
t_{SRI}	Asynchronous Reset or Set to Output/Feedback MUX Delay	—	0.30	—	0.30	ns

ispMACH 4032ZE and 4064ZE Logic Signal Connections: 48 TQFP (Cont.)

Pin Number	Bank Number	ispMACH 4032ZE	ispMACH 4064ZE
		GLB/MC/Pad	GLB/MC/Pad
43	0	CLK0/I	CLK0/I
44	0	A0/GOE0	A0/GOE0
45	0	A1	A1
46	0	A2	A2
47	0	A3	A4
48	0	A4	A6

ispMACH 4032ZE and 4064ZE Logic Signal Connections: 64 csBGA

Ball Number	Bank Number	ispMACH 4032ZE	ispMACH 4064ZE
		GLB/MC/Pad	GLB/MC/Pad
B2	-	TDI	TDI
B1	0	A5	A8
C2	0	A6	A10
C1	0	A7	A11
GND*	0	GND (Bank 0)	GND (Bank 0)
C3	0	NC	A12
E3	0	VCCO (Bank 0)	VCCO (Bank 0)
D1	0	A8	B15
D2	0	NC	B14
E1	0	A9	B13
D3	0	A10	B12
F1	0	A11	B11
E2	0	NC	B10
G1	0	NC	B9
F2	0	NC	B8
H1	-	TCK	TCK
E4	-	VCC	VCC
GND*	-	GND	GND
G2	0	A12	B6
H2	0	NC	B5
H3	0	A13	B4
GND*	0	NC	GND (Bank 0)
F4	0	NC	VCCO (Bank 0)
G3	0	A14	B3
F3	0	NC	B2
H4	0	A15	B0
G4	0	CLK1/I	CLK1/I
H5	1	CLK2/I	CLK2/I
F5	1	B0	C0
G5	1	B1	C1
G6	1	B2	C2
H6	1	B3	C4
F6	1	B4	C5
H7	1	NC	C6
H8	-	TMS	TMS
G7	1	B5	C8
F7	1	B6	C10
G8	1	B7	C11
GND*	1	GND (Bank 0)	GND (Bank 1)
F8	1	NC	C12
D6	1	VCCO (Bank 1)	VCCO (Bank 1)
E8	1	B8	D15

ispMACH 4032ZE and 4064ZE Logic Signal Connections: 64 csBGA (Cont.)

Ball Number	Bank Number	ispMACH 4032ZE	ispMACH 4064ZE
		GLB/MC/Pad	GLB/MC/Pad
E7	1	NC	D14
E6	1	B9	D13
D7	1	B10	D12
D8	1	NC	D11
C5	1	NC	D10
C7	1	B11	D9
C8	1	NC	D8
B8	-	TDO	TDO
D5	-	VCC	VCC
GND*	-	GND	GND
A8	1	B12	D7
A7	1	NC	D6
B7	1	NC	D5
A6	1	B13	D4
GND*	1	NC	GND (Bank 1)
C6	1	NC	VCCO (Bank 1)
B6	1	B14	D3
A5	1	NC	D2
B5	1	B15/GOE1	D0/GOE1
A4	1	CLK3/I	CLK3/I
C4	0	CLK0/I	CLK0/I
B4	0	A0/GOE0	A0/GOE0
B3	0	A1	A1
A3	0	A2	A2
A2	0	A3	A4
A1	0	A4	A6

* All bonded grounds are connected to the following two balls, D4 and E5.

ispMACH 4064ZE Logic Signal Connections: 64 ucBGA

Ball Number	Bank Number	GLB/MC/Pad
A1	-	TDI
B1	0	A8
B2	0	A10
B3	0	A11
GND*	0	GND (Bank 0)
C1	0	A12
C3	0	VCCO (Bank 0)
C2	0	B15
D1	0	B14
D2	0	B13
D3	0	B12
E1	0	B11
E2	0	B10
E3	0	B9
F1	0	B8
F2	-	TCK
E4	-	VCC
GND*	-	GND
H2	0	B6
H1	0	B5
G1	0	B4
GND*	0	GND (Bank 0)
F3	0	VCCO (Bank 0)
G2	0	B3
G3	0	B2
H3	0	B0
G4	0	CLK1/I
F4	1	CLK2/I
H4	1	C0
H5	1	C1
G5	1	C2
H6	1	C4
H7	1	C5
H8	1	C6
G8	-	TMS
G7	1	C8
G6	1	C10
F8	1	C11
GND*	1	GND (Bank 1)
F7	1	C12
F6	1	VCCO (Bank 1)
F5	1	D15
E8	1	D14

**ispMACH 4064ZE, 4128ZE and 4256ZE Logic Signal Connections:
100 TQFP (Cont.)**

Pin Number	Bank Number	LC4064ZE	LC4128ZE	LC4256ZE
		GLB/MC/Pad	GLB/MC/Pad	GLB/MC/Pad
42	1	C1	E2	I6
43	1	C2	E4	I10
44	1	C3	E6	I12
45	1	VCCO (Bank 1)	VCCO (Bank 1)	VCCO (Bank 1)
46	1	GND (Bank 1)	GND (Bank 1)	GND (Bank 1)
47	1	C4	E8	J2
48	1	C5	E10	J6
49	1	C6	E12	J10
50	1	C7	E14	J12
51	-	GND	GND	GND
52	-	TMS	TMS	TMS
53	1	C8	F0	K12
54	1	C9	F2	K10
55	1	C10	F4	K6
56	1	C11	F6	K2
57	1	GND (Bank 1)	GND (Bank 1)	GND (Bank 1)
58	1	C12	F8	L12
59	1	C13	F10	L10
60	1	C14	F12	L6
61	1	C15	F13	L4
62*	1	I	I	I
63	1	VCCO (Bank 1)	VCCO (Bank 1)	VCCO (Bank 1)
64	1	D15	G14	M4
65	1	D14	G12	M6
66	1	D13	G10	M10
67	1	D12	G8	M12
68	1	GND (Bank 1)	GND (Bank 1)	GND (Bank 1)
69	1	D11	G6	N2
70	1	D10	G5	N6
71	1	D9	G4	N10
72	1	D8	G2	N12
73*	1	I	I	I
74	-	TDO	TDO	TDO
75	-	VCC	VCC	VCC
76	-	GND	GND	GND
77*	1	I	I	I
78	1	D7	H13	O12
79	1	D6	H12	O10
80	1	D5	H10	O6
81	1	D4	H8	O2
82	1	GND (Bank 1)	GND (Bank 1)	GND (Bank 1)

**ispMACH 4064ZE, 4128ZE and 4256ZE Logic Signal Connections:
100 TQFP (Cont.)**

Pin Number	Bank Number	LC4064ZE	LC4128ZE	LC4256ZE
		GLB/MC/Pad	GLB/MC/Pad	GLB/MC/Pad
83	1	VCCO (Bank 1)	VCCO (Bank 1)	VCCO (Bank 1)
84	1	D3	H6	P12
85	1	D2	H4	P10
86	1	D1	H2	P6
87	1	D0/GOE1	H0/GOE1	P2/GOE1
88	1	CLK3/I	CLK3/I	CLK3/I
89	0	CLK0/I	CLK0/I	CLK0/I
90	-	VCC	VCC	VCC
91	0	A0/GOE0	A0/GOE0	A2/GOE0
92	0	A1	A2	A6
93	0	A2	A4	A10
94	0	A3	A6	A12
95	0	VCCO (Bank 0)	VCCO (Bank 0)	VCCO (Bank 0)
96	0	GND (Bank 0)	GND (Bank 0)	GND (Bank 0)
97	0	A4	A8	B2
98	0	A5	A10	B6
99	0	A6	A12	B10
100	0	A7	A14	B12

* This pin is input only.

**ispMACH 4064ZE, 4128ZE and 4256ZE Logic Signal Connections:
144 csBGA (Cont.)**

Ball Number	Bank Number	LC4064ZE	LC4128ZE	LC4256ZE
		GLB/MC/Pad	GLB/MC/Pad	GLB/MC/Pad
J12	1	NC Ball	NC Ball	L14
J11	1	NC Ball	NC Ball	L12
H10	1	NC Ball	F8	L10
H12	1	C12	F9	L8
G11	1	C13	F10	L6
H11	1	C14	F12	L4
G12	1	C15	F13	L2
G10*	1	I	F14	L0
G9	1	VCCO (Bank 1)	VCCO (Bank 1)	VCCO (Bank 1)
F12	1	D15	G14	M0
F11	1	D14	G13	M2
E11	1	D13	G12	M4
E12	1	D12	G10	M6
D10	1	NC Ball	G9	M8
F10	1	NC Ball	G8	M10
D12	1	NC Ball	NC Ball	M12
F8	1	GND (Bank 1)	GND (Bank 1)	GND (Bank 1)
E10	1	D11	G6	N2
D11	1	D10	G5	N4
E9	1	D9	G4	N6
C12	1	D8	G2	N8
C11*	1	I	G1	N10
B12	1	NC Ball	G0	N12
F9	1	NC Ball	VCCO (Bank 1)	VCCO (Bank 1)
B11	-	TDO	TDO	TDO
E8	-	VCC	VCC	VCC
F7	-	GND	GND	GND
A12	1	NC Ball	NC Ball	O14
C10	1	NC Ball	NC Ball	O12
B10	1	NC Ball	H14	O10
A11*	1	I	H13	O8
D9	1	D7	H12	O6
B9	1	D6	H10	O4
C9	1	D5	H9	O2
A10	1	D4	H8	O0
E7	1	GND (Bank 1)	GND (Bank 1)	GND (Bank 1)
D8	1	VCCO (Bank 1)	VCCO (Bank 1)	VCCO (Bank 1)
A9	1	NC Ball	H6	P12
B8	1	NC Ball	H5	P10
C8	1	D3	H4	P8
A8	1	D2	H2	P6
D7	1	D1	H1	P4
B7	1	D0/GOE1	H0/GOE1	P2/GOE1

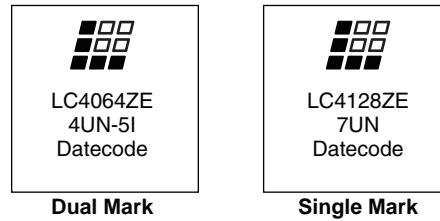
**ispMACH 4064ZE, 4128ZE and 4256ZE Logic Signal Connections:
144 csBGA (Cont.)**

Ball Number	Bank Number	LC4064ZE	LC4128ZE	LC4256ZE
		GLB/MC/Pad	GLB/MC/Pad	GLB/MC/Pad
C7	1	CLK3/I	CLK3/I	CLK3/I
E6	0	NC Ball	GND (Bank 0)	GND (Bank 0)
A7	0	CLK0/I	CLK0/I	CLK0/I
E5	-	VCC	VCC	VCC
D6	0	A0/GOE0	A0/GOE0	A2/GOE0
B6	0	A1	A1	A4
A6	0	A2	A2	A6
C6	0	A3	A4	A8
B5	0	NC Ball	A5	A10
A5	0	NC Ball	A6	A12
D5	0	VCCO (Bank 0)	VCCO (Bank 0)	VCCO (Bank 0)
F5	0	GND (Bank 0)	GND (Bank 0)	GND (Bank 0)
A4	0	A4	A8	B2
B4	0	A5	A9	B4
C5	0	A6	A10	B6
A3	0	A7	A12	B8
C4	0	NC Ball	A13	B10
B3	0	NC Ball	A14	B12
A2	0	NC Ball	NC Ball	B14

* This pin is input only for the LC4064ZE.

ispMACH 4128ZE and 4256ZE Logic Signal Connections: 144 TQFP (Cont.)

Pin Number	Bank Number	LC4128ZE	LC4256ZE
		GLB/MC/Pad	GLB/MC/Pad
43	0	D9	G4
44	0	D8	G2
45*	0	NC	I
46	0	GND (Bank 0)	GND (Bank 0)
47	0	VCCO (Bank 0)	VCCO (Bank 0)
48	0	D6	H12
49	0	D5	H10
50	0	D4	H8
51	0	D2	H6
52	0	D1	H4
53	0	D0	H2
54	0	CLK1/I	CLK1/I
55	1	GND (Bank 1)	GND (Bank 1)
56	1	CLK2/I	CLK2/I
57	-	VCC	VCC
58	1	E0	I2
59	1	E1	I4
60	1	E2	I6
61	1	E4	I8
62	1	E5	I10
63	1	E6	I12
64	1	VCCO (Bank 1)	VCCO (Bank 1)
65	1	GND (Bank 1)	GND (Bank 1)
66	1	E8	J2
67	1	E9	J4
68	1	E10	J6
69	1	E12	J8
70	1	E13	J10
71	1	E14	J12
72*	1	NC	I
73	-	GND	GND
74	-	TMS	TMS
75	1	VCCO (Bank 1)	VCCO (Bank 1)
76	1	F0	K12
77	1	F1	K10
78	1	F2	K8
79	1	F4	K6
80	1	F5	K4
81	1	F6	K2
82	1	GND (Bank 1)	GND (Bank 1)
83	1	F8	L14
84	1	F9	L12
85	1	F10	L10

Figure 20. Mark Format for 64 ucBGA and 132 ucBGA Packages

Lead-Free Packaging
Commercial

Device	Part Number	Macrocells	Voltage	t _{PD}	Package	Pin/Ball Count	I/O	Grade
LC4032ZE	LC4032ZE-4TN48C	32	1.8	4.4	Lead-Free TQFP	48	32	C
	LC4032ZE-5TN48C	32	1.8	5.8	Lead-Free TQFP	48	32	C
	LC4032ZE-7TN48C	32	1.8	7.5	Lead-Free TQFP	48	32	C
	LC4032ZE-4MN64C	32	1.8	4.4	Lead-Free csBGA	64	32	C
	LC4032ZE-5MN64C	32	1.8	5.8	Lead-Free csBGA	64	32	C
	LC4032ZE-7MN64C	32	1.8	7.5	Lead-Free csBGA	64	32	C
LC4064ZE	LC4064ZE-4TN48C	64	1.8	4.7	Lead-Free TQFP	48	32	C
	LC4064ZE-5TN48C	64	1.8	5.8	Lead-Free TQFP	48	32	C
	LC4064ZE-7TN48C	64	1.8	7.5	Lead-Free TQFP	48	32	C
	LC4064ZE-4TN100C	64	1.8	4.7	Lead-Free TQFP	100	64	C
	LC4064ZE-5TN100C	64	1.8	5.8	Lead-Free TQFP	100	64	C
	LC4064ZE-7TN100C	64	1.8	7.5	Lead-Free TQFP	100	64	C
	LC4064ZE-4MN64C	64	1.8	4.7	Lead-Free csBGA	64	48	C
	LC4064ZE-5MN64C	64	1.8	5.8	Lead-Free csBGA	64	48	C
	LC4064ZE-7MN64C	64	1.8	7.5	Lead-Free csBGA	64	48	C
	LC4064ZE-4MN144C	64	1.8	4.7	Lead-Free csBGA	144	64	C
LC4064ZE-5MN144C	64	1.8	5.8	Lead-Free csBGA	144	64	C	
LC4064ZE-7MN144C	64	1.8	7.5	Lead-Free csBGA	144	64	C	
LC4128ZE	LC4128ZE-5TN100C	128	1.8	5.8	Lead-Free TQFP	100	64	C
	LC4128ZE-7TN100C	128	1.8	7.5	Lead-Free TQFP	100	64	C
	LC4128ZE-5TN144C	128	1.8	5.8	Lead-Free TQFP	144	96	C
	LC4128ZE-7TN144C	128	1.8	7.5	Lead-Free TQFP	144	96	C
	LC4128ZE-5UMN132C	128	1.8	5.8	Lead-Free ucBGA	132	96	C
	LC4128ZE-7UMN132C	128	1.8	7.5	Lead-Free ucBGA	132	96	C
	LC4128ZE-5MN144C	128	1.8	5.8	Lead-Free csBGA	144	96	C
	LC4128ZE-7MN144C	128	1.8	7.5	Lead-Free csBGA	144	96	C
LC4256ZE	LC4256ZE-5TN100C	256	1.8	5.8	Lead-Free TQFP	100	64	C
	LC4256ZE-7TN100C	256	1.8	7.5	Lead-Free TQFP	100	64	C
	LC4256ZE-5TN144C	256	1.8	5.8	Lead-Free TQFP	144	96	C
	LC4256ZE-7TN144C	256	1.8	7.5	Lead-Free TQFP	144	96	C
	LC4256ZE-5MN144C	256	1.8	5.8	Lead-Free csBGA	144	108	C
	LC4256ZE-7MN144C	256	1.8	7.5	Lead-Free csBGA	144	108	C